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10/519,175	NAGANO, et al	
Examiner	Art Unit	
Calvin Lee	2892	16869S- 137100US

	SEARCHED				
Class	Subclass	Date	Examiner		
174 349/	/264 187	04/14/2009	MDH		
257	673	#	#		
438	114,123	#	#		
Update	Search	03/13/2008	#		
#	#	07/17/2009	#		
#	#	04/08/2009	CL		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
438	114	04/08/2009	CL		
257	673	#	#		

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
Keyword Search EAST and cls/scl 438/114 & 257/673	04/14/2009	MDH

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